

## APT12067JLL

**1200V 17A 0.670**Ω

# POWER MOS 7™

Power MOS 7<sup>TM</sup> is a new generation of low loss, high voltage, N-Channel enhancement mode power MOSFETS. Both conduction and switching losses are addressed with Power MOS 7<sup>TM</sup> by significantly lowering  $R_{\rm DS(ON)}$  and  $Q_{\rm g}$ . Power MOS 7<sup>TM</sup> combines lower conduction and switching losses along with exceptionally fast switching speeds inherent with APT's patented metal gate structure.



Increased Power Dissipation

• Lower Miller Capacitance

Easier To Drive

• Lower Gate Charge, Qg

Popular SOT-227 Package





#### **MAXIMUM RATINGS**

All Ratings:  $T_C = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter	APT12067JLL	UNIT		
V <sub>DSS</sub>	Drain-Source Voltage	1200	Volts		
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	17	Amno		
I <sub>DM</sub>	Pulsed Drain Current ①	68	Amps		
V <sub>GS</sub>	Gate-Source Voltage Continuous	±30	Volta		
V <sub>GSM</sub>	Gate-Source Voltage Transient	±40	Volts		
P <sub>D</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C	460	Watts		
, D	Linear Derating Factor	3.68	W/°C		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	- °C		
T <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	300	] [		
I <sub>AR</sub>	Avalanche Current (Repetitive and Non-Repetitive)	17	Amps		
E <sub>AR</sub>	Repetitive Avalanche Energy ①	50			
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>(4)</sup>	2500	- mJ		

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $(V_{GS} = 0V, I_D = 250\mu\text{A})$	1200			Volts
I <sub>D(on)</sub>	On State Drain Current ② $(V_{DS} > I_{D(on)} \times R_{DS(on)} Max, V_{GS} = 10V)$	17			Amps
R <sub>DS(on)</sub>	Drain-Source On-State Resistance ② (V <sub>GS</sub> = 10V, 0.5 I <sub>D[Cont.]</sub> )			0.670	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current $(V_{DS} = V_{DSS}, V_{GS} = 0V)$			100	μΑ
	Zero Gate Voltage Drain Current ( $V_{DS} = 0.8 V_{DSS}$ , $V_{GS} = 0V$ , $T_{C} = 125$ °C)			500	
I <sub>GSS</sub>	Gate-Source Leakage Current (V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V)			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = 2.5 \text{mA})$	3		5	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

APT Website - http://www.advancedpower.com

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Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		4990		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V		690		рF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		521		
$Q_g$	Total Gate Charge <sup>③</sup>	V <sub>GS</sub> = 10V		176		
Q <sub>gs</sub>	Gate-Source Charge	$V_{DD} = 0.5 V_{DSS}$		21		nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	I <sub>D</sub> = I <sub>D[Cont.]</sub> @ 25°C		105		
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>GS</sub> = 15V		19		
t <sub>r</sub>	Rise Time	$V_{DD} = 0.5 V_{DSS}$		11		ns
t <sub>d(off)</sub>	Turn-off Delay Time	$I_{D} = I_{D[Cont.]} @ 25^{\circ}C$ $R_{G} = 0.6\Omega$		52		113
t <sub>f</sub>	Fall Time	$R_{G} = 0.6\Omega$		18		

#### SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
I <sub>s</sub>	Continuous Source Current (Body Diode)			17	A
I <sub>SM</sub>	Pulsed Source Current (1) (Body Diode)			68	Amps
V <sub>SD</sub>	Diode Forward Voltage ② (V <sub>GS</sub> = 0V, I <sub>S</sub> = -I <sub>D[Cont.]</sub> )			1.3	Volts
t <sub>rr</sub>	Reverse Recovery Time $(I_S = -I_{D[Cont.]}, dI_S/dt = 100A/\mu s)$		1080		ns
Qrr	Reverse Recovery Charge $(I_S = -I_{D[Cont.]}, dI_S/dt = 100A/\mu s)$		22.0		μC
dv/ <sub>dt</sub>	Peak Diode Recovery dv/ <sub>dt</sub> ⑤			10	V/ns

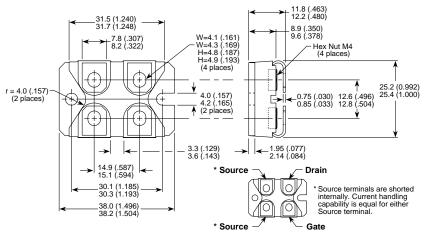
#### THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{ hetaJC}$	Junction to Case			0.27	°C/W
$R_{\thetaJA}$	Junction to Ambient	·		40	

<sup>1</sup> Repetitive Rating: Pulse width limited by maximum junction temperature.

- 2 Pulse Test: Pulse width < 380 µs, Duty Cycle < 2%
- 3 See MIL-STD-750 Method 3471
- 4 Starting T<sub>i</sub> = +25°C, L = 17.30mH, R<sub>G</sub> = 25 $\Omega$ , Peak I<sub>L</sub> = 17A
- device itself.  $I_S \le -I_{D[Cont.]}$  di/dt  $\le 700 \text{A}/\mu \text{s}$   $V_R \le V_{DSS}$   $T_J \le 150 ^{\circ} \text{C}$  APT Reserves the right to change, without notice, the specifications and information contained herein.

### SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)